

High-temperature fiber-optic Fabry-Perot interferometric sensors

Wenhui Ding,¹ Yi Jiang,¹ Ran Gao,^{1,a)} and Yuewu Liu²

¹School of Optoelectronics, Beijing Institute of Technology, Beijing 100081, China ²Key Laboratory for Mechanics in Fluid Solid Coupling Systems, Institute of Mechanics, Chinese Academy of Science, Beijing 100190, China

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A photonic crystal fiber (PCF) based high-temperature fiber-optic sensor is proposed and experimentally demonstrated. The sensor head is a Fabry-Perot cavity manufactured with a short section of endless single-mode photonic crystal fiber (ESM PCF). The interferometric spectrum of the Fabry-Perot interferometer is collected by a charge coupled device linear array based micro spectrometer. A high-resolution demodulation algorithm is used to interrogate the peak wavelengths. Experimental results show that the temperature range of 1200 °C and the temperature resolution of 1 °C are achieved. © 2015 AIP Publishing LLC. [http://dx.doi.org/10.1063/1.4919409]

INTRODUCTION

The igniter wire is an essential component in the electro explosive devices. The performance of the igniter wire is affected by the temperature which could be controlled by the driver current. In conventional methods, the temperature is measured by using a thermocouple or thermal resistor. However, these methods are unsuitable for the temperature measurement of an igniter wire which is as small as tens of micrometers in size. Fiber-optic temperature sensors exhibit outstanding advantages over conventional temperature sensors, such as small size, high precision, and wide measurement range.¹ A large number of fiber-optic temperature sensors have been proposed and demonstrated.^{2,3} Among them, optical fiber sensors based on fiber Bragg grating (FBG) and interferometer are particularly attractive because they are insensitive with the light source intensity. The FBG is an ideal sensor for the temperature measurement due to its advantages such as wavelength coding, wavelength modulation, and intrinsic property.⁴ However, the FBG sensor performs poor stability in the hightemperature environment and the grating would be erased completely when the temperature exceeds 300 °C.5 Some interferometric temperature sensors can measure a wide range as high as 1600 °C.^{6,7} However, the configuration of these sensors is complex and the sensing element is an extrinsic sensor.

In this letter, we proposed a high-temperature fiber-optic Fabry-Perot interferometric (FFPI) sensor. The sensor is fabricated by splicing a segment of the endless single mode photonic crystal fiber (ESM PCF) to a single mode fiber (SMF28). The reflected spectrum of the FFPI is interrogated by using a micro spectrometer. Experimental results show that the temperature measurement range of the proposed sensor exceeds 1200 °C.

OPERATION PRINCIPLE

The fiber-optic temperature sensor is constructed by splicing a SMF with a short segment of the ESM PCF (SM-7.0-PCF, YOFC CO.), and the free end face of the PCF is cleaved and polished to a certain length L. The operation principle of the sensor is shown in Fig. 1(a) and the microscope photograph of the sensor is illustrated in Fig. 1(b). At the fiber splice, a reflector R_1 with a reflectivity of 1.2% is formed because of the small difference in refractive index between the SMF and the PCF. The end face of the PCF acts as another reflector R_2 due to the Fresnel reflection. Thus, an intrinsic Fabry-Perot interferometer is formed. The material of the EMS PCF is pure silica. The fiber has a 7 μ m diameter core, the average diameter of voids is 2.57 μ m, and the average separation between the voids is 5.12 μ m.

When the external temperature increases, the effective refractive index and the length of the PCF will be changed because of the thermo-optics effect and the thermal expansion effect. Thus, the change of the optical path difference (OPD), Δd , can be expressed as

$$\Delta d = 2L \cdot \left(\frac{dn_{eff}}{dT} + n_{eff} \times \frac{dL}{L \cdot dT}\right) \cdot \Delta T$$
$$= 2L(\sigma_T + n_{eff}\alpha_T)\Delta T, \tag{1}$$

where Δd is the change of the OPD, n_{eff} is the effective refractive index of pure silica, L is the physical length of the cavity, σ_T is the thermo-optics coefficient, and α_T is the thermal expansion coefficient.

In the optical spectrum of the interferometer, with the increase of the temperature, peak wavelengths shift toward longer wavelength. When a peak wavelength changes from λ_0 to λ_n , the change of the OPD can be expressed as⁸

$$\Delta d = k \times \Delta \lambda = k(\lambda_n - \lambda_0), \tag{2}$$

where *k* is the interferometric order of the fringe, which is an integer.

From Eqs. (1) and (2), the relationship between the change of a peak wavelength $\Delta\lambda$ and the temperature variation ΔT can be obtained as

$$\begin{aligned} \Delta \lambda &= \lambda_n - \lambda_0 \\ &= \frac{2}{k} \times L \times (\sigma_T + n_{eff} \cdot \alpha_T) \times \Delta T \\ &= \lambda_0 \times (\sigma_T / n_{eff} + \alpha_T) \times \Delta T. \end{aligned}$$
(3)

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a)Author to whom correspondence should be addressed. Electronic mail: bitjy@bit.edu.cn.

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FIG. 1. (a) The operation principle. (b) The cross section of the ESM PCF.

For the sensor constructed in our experiment, the effective refractive index n_{eff} , the thermo-optics coefficient σ_T , and the thermal expansion coefficient α_T of the pure silica are given as $n_{eff} = 1.4575$, $\sigma_T = 1.45 \times 10^{-5}$ /°C, and α_T $= 0.55 \times 10^{-6}$ /°C, respectively.⁹ The peak wavelength λ_0 is the initial peak wavelength. The sensor length *L* can be roughly measured by using white-light interferometry (WLI).¹⁰ Thus, the wavelength shift, $\Delta\lambda$, is proportional to the temperature variation ΔT . So, the change of the temperature can be measured by interrogating the peak wavelength in the optical spectrum of the FFPI.

EXPERIMENTAL SETUP

The experimental setup for interrogating the FFPI sensor is shown in Fig. 2. An unflattened amplified spontaneous emission (ASE) source with a wavelength covering 1525-1565 nm is used to illuminate a FFPI with a cavity length of 148 μ m. The reflected spectrum of FFPI is collected by using a micro spectrometer (BaySpec FBGA-F-1525-1565), and the optical spectrum of the ASE source is shown in Fig. 3(a). Fig. 3(b) shows the reflected spectrum of FFPI. Due to the spectral profile of the unflattened ASE source, the peak wavelength around 1530 nm is significantly stronger than others.

The spectrum of the sensor is first sampled into a personal computer (PC). Due to the limitation pixels (512 pixels) and the narrow wavelength range (1513-1572 nm), the wavelength resolution of the micro spectrometer is only 0.115 nm. Mean-while, the spectrum of the sensor is a sine curve, or the peaks in the optical spectrum are not sharp; thus, there is much uncertainty in determining peak positions, which will reduce the measurement resolution. In our experiment, the resolution of the micro spectrometer is improved by a sub-division method. The sub-division method is developed by using the spline interpolation arithmetic.¹¹





FIG. 3. (a) Optical spectrum of the ASE and (b) the reflected optical spectrum of the Fabry-Perot interferometer.

After the optical spectrum is sampled into the computer, we resample the pixels along the wavelength. The resampling interval of the wavelength is set to be 1 pm. So, the length of the resampled sub-pixels is 40 000 for the wavelength range from 1525 to 1565 nm. The sub-pixels with the length of 40 000 are recovered by using spline interpolation arithmetic. Then, the wavelength interval of 1 pm within the wavelength range of 40 nm can be obtained. The wavelength resolution of the micro spectrometer is improved from 0.115 nm to 1 pm.

EXPERIMENTS AND DISCUSSION

The temperature response of the sensor is experimentally investigated. The length of the sensor is 148 μ m of which the size is the same as that of the igniter wire (~100 μ m). The small size of the sensor head is easy to be touched on the surface of the igniter wire. First, the sensor head was calibrated by placing the sensor into a muffle furnace. The temperature of the muffle furnace was adjusted from the room temperature (17 °C) to the 1200 °C. A peak wavelength with the change of the temperature was obtained, as shown in Fig. 4. The straight line in Fig. 4 is the linear fitting curve. The obtained linear fitting equation is $\lambda = 0.01$ T + 1537, which indicates the relationship between the wavelength shift and the temperature is 0.01 nm/°C.

Then, we measured the temperature of an igniter wire by touching the PCF sensor on the surface of the igniter wire, as shown in the inset figure of Fig. 2. When the current is zero, the temperature is measured as 31 °C by using a standard thermometer. Different driving currents were applied on the igniter



FIG. 2. Schematic diagram of the experimental setup.

p. FIG. 4. The relationship between the peak wavelength and temperature.

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FIG. 5. (a) The measurement results of the temperature of the igniter wire and (b) the relationship between the temperature change ΔT and the square of the driving current I^2 .

wire, and the temperature of the igniter wire is measured by interrogating the peak wavelength of the interferometric spectrum. The measured results are shown in Fig. 5(a). With the increase of the driving current, the temperature of the igniter wire is increased and the peak wavelength of the FP interferometer red-shift simultaneously. Because the temperature sensitivity of the sensor is 0.01 nm/°C, a temperature change of 1251 °C is calculated when the peak wavelength shift is 13.88 nm. During the experiment, the fringe visibility of the optical spectrum has no distinct change even if temperature exceeds 1200 °C.

The relationship between the change of temperature and the driving current can be written as 12

$$\Delta T = CI^2,\tag{4}$$

where *C* is a constant determined by the material and the size of igniter wire, *I* is the driving current, and ΔT is the change of the temperature. Given that the constant *C* is 6.46 in our experiment, which is calculated by using the parameters of the igniter wire.¹² The measured results are compared with that calculated by using Eq. (4), as shown in Fig. 5(b). The measured results are in good agreement with that of theoretical prediction.

To test the stability and resolution of the system, a peak wavelength of the interferometer was measured for 1 min at room temperature. The experimental results are shown in Fig. 6(a), in which the peak wavelength is 1527.115 nm and the variation is ± 5 pm during 6000 measurements. In the method without the sub-division, a temperature resolution of 11.5 °C corresponding to the wavelength resolution of 0.115 nm is much lower than that of the sub-division method. Besides, a continuous test was performed when the temperature was changed from 400 °C to 480 °C with a temperature interval temperature of 10 °C. The experimental results are shown in Fig. 6(b). A peak wavelength of the sensor shifts from 1534.730 to 1535.605 nm in 9 steps during the test. The change



FIG. 6. The experimental result: (a) a continuous test at a fixed temperature, (b) a continuous testing when the temperature was changed from 400 to 480 $^{\circ}$ C, and (c) a continuous testing when the current was changed from 200 to 1000 mA.

of the peak wavelength is approximately 100 pm in each step. Moreover, the interferometer was continuously tested by adjusting the driving current of the igniter wire from 200 mA to 1000 mA with a current interval of 200 mA. With the increase of the driving current, the temperature of the igniter wire increases, which results in the red-shift of the peak wavelength. The experimental results are shown in Fig. 6(c) with the peak wavelength shift from 1533.250 nm to 1540.395 nm in 5 steps during the test. It is noted that the corresponding wavelength is also fluctuated at the beginning of each step, because the temperature of the igniter wire would become unstable in each staircase of current, as shown in Fig. 6(c).

CONCLUSION

In conclusion, a PCF based FFPI high-temperature sensor is presented and experimentally demonstrated. The optical interferometric spectrum of the FFPI is interrogated by using a micro spectrometer, and a sub-division technique is developed to improve the wavelength resolution. Experimental results show that the peak wavelength resolution of 10 pm and the temperature sensitivity of 10 pm/°C are achieved. The reflected spectrum keeps stable even when the temperature exceeds 1200 °C, showing that the FFPI based sensor exhibits a wide temperature measurement range.

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